

Notice of References Cited	Application/Control No. 10/762,330		Applicant(s)/Patent Under Reexamination TANAKA, SATORU	
	Examiner BENJAMIN E. LANIER		Art Unit 2432	Page 1 of 1

U.S. PATENT DOCUMENTS

★		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
★	A	US-2003/0055994	03-2003	Herrmann et al.	709/229
	B	US-			
	C	US-			
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FOREIGN PATENT DOCUMENTS

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